	COUNT	DESCRIPTION OF REVI		SIONS BY CHKD		DATE	ATE COL		T DESC	RIPTION OF R	ON OF REVISIONS		СНК	D D	ATE	
Δ							<u> </u>							4		
		L BLE STANDARI						Δ								
AFF	LIOAL	Operating			0-		NE <sup>0</sup> 0 /N	. 4\		Storage		1	00.	0000		۵)
RATING		Temperature Range Operating Humidity Range		-55°C to +105°C (Note1)						Temperature Range -10°C to +60°C (N					:3)	
				I ZU% TO 8U% (NOTEZ) I					Storage Range	Humidity	40% to 70% (Note3)					
		Applicable Connector		DF51K-*(D)S-2C (###)						Voltage	/oltage 250V AC/DC					
		Applicable Cable								Current		AWG 22 : 2A			2A	
		Insulation Diameter		$\phi$ 1.2 $\sim \phi$ 1.45 mm												
			T				PECI	FIC	ATIC	<u> NS</u>						
ITEM TEST METHOD REQUIREMENTS												QT	AT			
CONSTRUCTION  General Examination			Tresseller and because the second								T					
Gene	eral Exar	mination	y and by measuring instrument.						Accord	According to drawing.					0	
Mark	ing		Confirmed visually.													0
ELE	CTRI	CAL CHARAC	TERI	STICS	S											
Cont	act Res	istance	20mV MAX, 1mA (DC or 1000Hz).								MAX.					
Milliv	olt Leve	el Method													0	-
ME	CHAN	ICAL CHARAC	TER	ISTIC	22											
			1		_	1				①C==		20 O MAY	,		$\Box$	1
wecr	namicai (	Operation	30 times insertion and extraction.								①Contact resistance: 30mΩ MAX					-
(Sn Plating)										(2)No (	②No damage, crack or looseness of parts.					
Meck	nanical (	Operation	50 times insertion and extraction.							①Con	①Contact resistance: $30m\Omega$ MAX					l _
		(Au Plating)								②No (	②No damage, crack or looseness of parts.					
Vibra	ation		Frequency 10 to 55 Hz, single amplitude 0.75 mm,							) (1)No.4	①No electrical discontinuity of 1 $\mu$ s.					
			at 10 cycles for 3 direction.								②No damage, crack or looseness of parts.					-
01			Acceleration 490 m/s <sup>2</sup> duration of pulse 11 ms at 3 times for 3 directions.								damage, crack or	looseness	of part	S.	$\vdash$	
Shoc	K									t 3	3					-
EN,	<u>VIRON</u>	IMENTAL CHA	RAC	TERI	STICS	<u>S</u>										
Damı	p Heat		Exposed at 40 $\pm$ 2 $^{\circ}$ C , humidity 90 to 95 %, 96 h.							n. ①Con	$\bigcirc$ Contact resistance: 30 m $\Omega$ MAX.					
		(Steady State)	(After leaving the room temperature for 1 to 2h.)							②No (	②No damage, crack or looseness of parts.					-
Rapid	Change	of	Temperature −55 °C→ +105 °C								①Contact resistance: 30 mΩ MAX.					
Temperature																
rem	perature		Time 30min → 30min Under 5 Cycles.							les. Zino (	with damage, crack of tooseness of parts.					-
	(The transferring time of the tank is 2 to 3 MIN)															
(After leaving the room temperature for 1 to 2h.)																
Note Note	Remarks  Note 1: Include the temperature rising by current.  Note 2: No condensing  Note 3: Apply to the condition of long term storage for unused products before pcb on board, after pcb board, operating temperature and humidity range is applied for interim storage during transportation.															
								DRAW	/N	DESIGN	IED CHECK	ED I AI	PROVE	ъΤ	RELEA	SED
								51V WH		Debia			, and the RE		KLLLA	\SED
						J	J.S CHOI		J.S Cł	IOI S.M.L	<b>ІМ</b>   Т.			<u>EN</u>	ENG	
						1	17.12.22		17.12.	22 17.12	22   1			-	20. 02. 13	
Unles	s otherw	vise specified, refer to	o IEC 60	)512.			'	17.12.22		17.12.	17.12				DEF	<b>"</b> 」
NOT		QUALIFICATION			SSURA	NCE TE	EST O:	APPL	CABL	E TEST	1	1				
	HIRC	SE KOREA CO	"LTD.	D. SPECIFICATION SH					HEET	EET PART NO. DF51K-22SCFA (800)						
COD	E NO.(OL	_D)		DRAWING NO.					CODE	NO.	1 /					1 /
CL				ELC4-611496						CL 6652-0043-1-800						
			===: :::::3												<i>y</i> '	